

**Search Notes**

Application/Control No.

10/784,716

Examiner

John Q. Nguyen

Applicant(s)/Patent under  
Reexamination

ISHIHARA ET AL.

Art Unit

3654

**SEARCHED**

Class	Subclass	Date	Examiner
Previous search updated		7/20/06	JN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR